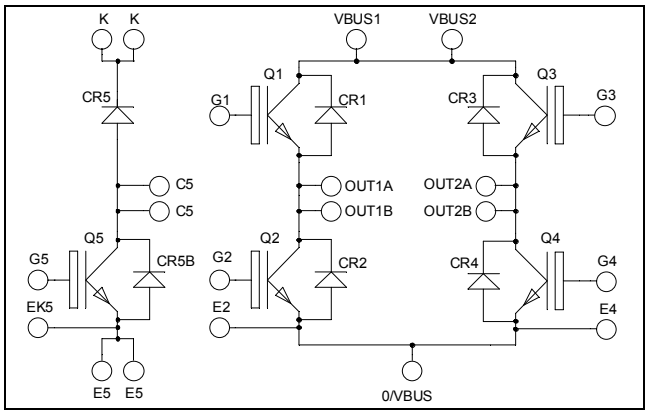
APTGV25H120BG

Boost chopper + Full - Bridge
NPT & Trench + Field Stop IGBT
Power module

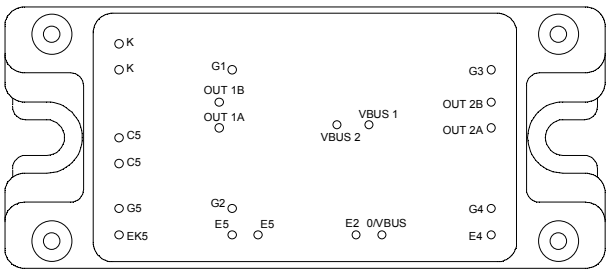
Trench & Field Stop IGBT Q1, Q3:
V_{CES} = 1200V , I_C = 25A @ Tc = 80°C

Fast NPT IGBT Q2, Q4:
V_{CES} = 1200V ; I_C = 25A @ Tc = 80°C

Fast NPT IGBT Q5:
V_{CES} = 1200V ; I_C = 50A @ Tc = 80°C



Full bridge top switches : Trench + Field Stop IGBT
Full bridge bottom switches : FAST NPT IGBT
Q5 boost chopper : FAST NPT IGBT



All multiple inputs and outputs must be shorted together
OUT1A/OUT1B ; VBUS1/VBUS2 ; K/K ; …

Application

- Solar converter

Features

- ***Q2, Q4, Q5(FAST Non Punch Through (NPT) IGBT)***
  - Switching frequency up to 100 kHz
  - RBSOA & SCSOA rated
  - Low tail current
- ***Q1, Q3 (Trench & Field Stop IGBT)***
  - Low voltage drop
  - Switching frequency up to 20 kHz
  - RBSOA & SCSOA rated
  - Low tail current
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration

Benefits

- Optimized conduction & switching losses
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive T_C of V_{CEsat}
- RoHS Compliant

All ratings @ T_j = 25°C unless otherwise specified

1. Full bridge top switches

1.1 Top Trench + Field Stop IGBT characteristics

Absolute maximum ratings

Symbol	*Parameter*		*Max ratings*	*Unit*
V_{CES}	Collector - Emitter Breakdown Voltage		1200	V
I_C	Continuous Collector Current	T_C = 25°C	40	A
		T_C = 80°C	25	
I_{CM}	Pulsed Collector Current	T_C = 25°C	50	
V_{GE}	Gate – Emitter Voltage		±20	V
P_D	Maximum Power Dissipation	T_C = 25°C	156	W
RBSOA	Reverse Bias Safe Operation Area	T_j = 125°C	50A @ 1150V	

Electrical Characteristics

Symbol	*Characteristic*	*Test Conditions*		*Min*	*Typ*	*Max*	*Unit*
I_{CES}	Zero Gate Voltage Collector Current	V_{GE} = 0V, V_{CE} = 1200V				250	µA
$V_{CE(sat)}$	Collector Emitter Saturation Voltage	V_{GE} = 15V, I_C = 25A	T_j = 25°C		1.7	2.1	V
			T_j = 125°C		2.0		
$V_{GE(th)}$	Gate Threshold Voltage	V_{GE} = V_{CE}, I_C = 1mA		5.0	5.8	6.5	V
I_{GES}	Gate – Emitter Leakage Current	V_{GE} = 20V, V_{CE} = 0V				400	nA

Dynamic Characteristics

Symbol	*Characteristic*	*Test Conditions*		*Min*	*Typ*	*Max*	*Unit*
C_{ies}	Input Capacitance	V_{GE} = 0V, V_{CE} = 25V, f = 1MHz			1800		pF
C_{res}	Reverse Transfer Capacitance				82		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C), V_{GE} = ±15V, V_{Bus} = 600V, I_C = 25A, R_G = 27Ω			90		ns
T_r	Rise Time				30		
$T_{d(off)}$	Turn-off Delay Time				420		
T_f	Fall Time				70		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C), V_{GE} = ±15V, V_{Bus} = 600V, I_C = 25A, R_G = 27Ω			90		ns
T_r	Rise Time				50		
$T_{d(off)}$	Turn-off Delay Time				520		
T_f	Fall Time				90		
E_{on}	Turn-on Switching Energy	V_{GE} = ±15V, V_{Bus} = 600V, I_C = 25A, R_G = 27Ω	T_j = 25°C		1.9		mJ
			T_j = 125°C		2.5		
E_{off}	Turn-off Switching Energy		T_j = 25°C		1.9		
			T_j = 125°C		2.9		
R_{thJC}	Junction to Case Thermal resistance					0.8	°C/W

1.2 Top fast diode characteristics

Symbol	*Characteristic*	*Test Conditions*		*Min*	*Typ*	*Max*	*Unit*
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I_{RM}	Maximum Reverse Leakage Current	V_R=1200V	T_j = 25°C			100	µA
			T_j = 125°C			500	
I_F	DC Forward Current		Tc = 80°C		25		A
V_F	Diode Forward Voltage	I_F = 25A			2.6	3.1	V
		I_F = 50A			3.2		
		I_F = 25A	T_j = 125°C		1.8		
t_{rr}	Reverse Recovery Time	I_F = 25A V_R = 667V di/dt =200A/µs	T_j = 25°C		320		ns
			T_j = 125°C		360		
Q_{rr}	Reverse Recovery Charge		T_j = 25°C		480		nC
			T_j = 125°C		1800		
R_{thJC}	Junction to Case Thermal resistance					1.4	°C/W

2. Full bridge bottom switches

2.1 Bottom Fast NPT IGBT characteristics

Absolute maximum ratings

Symbol	*Parameter*		*Max ratings*	*Unit*
V_{CES}	Collector - Emitter Breakdown Voltage		1200	V
I_C	Continuous Collector Current	T_C = 25°C	40	A
		T_C = 80°C	25	
I_{CM}	Pulsed Collector Current	T_C = 25°C	100	
V_{GE}	Gate – Emitter Voltage		±20	V
P_D	Maximum Power Dissipation	T_C = 25°C	208	W
RBSOA	Reverse Bias Safe Operating Area	T_j = 125°C	50A@1150V	

Electrical Characteristics

Symbol	*Characteristic*	*Test Conditions*		*Min*	*Typ*	*Max*	*Unit*
I_{CES}	Zero Gate Voltage Collector Current	V_{GE} = 0V V_{CE} = 1200V	T_j = 25°C			250	µA
			T_j = 125°C			500	
$V_{CE(sat)}$	Collector Emitter saturation Voltage	V_{GE} =15V I_C = 25A	T_j = 25°C	2.5	3.2	3.7	V
			T_j = 125°C		4.0		
$V_{GE(th)}$	Gate Threshold Voltage	V_{GE} = V_{CE} , I_C = 1mA		4		6	V
I_{GES}	Gate – Emitter Leakage Current	V_{GE} = 20V, V_{CE} = 0V				400	nA

Dynamic Characteristics

Symbol	*Characteristic*	*Test Conditions*		*Min*	*Typ*	*Max*	*Unit*
C_{ies}	Input Capacitance	V_{GE} = 0V V_{CE} = 25V f = 1MHz			1650		pF
C_{oes}	Output Capacitance				250		
C_{res}	Reverse Transfer Capacitance				110		
Q_g	Total gate Charge	V_{GE} = 15V V_{Bus} = 300V I_C =25A			160		nC
Q_{ge}	Gate – Emitter Charge				10		
Q_{gc}	Gate – Collector Charge				70		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C) V_{GE} = 15V V_{Bus} = 400V I_C = 25A R_G = 22Ω			60		ns
T_r	Rise Time				50		
$T_{d(off)}$	Turn-off Delay Time				305		
T_f	Fall Time				30		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C) V_{GE} = 15V V_{Bus} = 400V I_C = 25A R_G = 22Ω			60		ns
T_r	Rise Time				50		
$T_{d(off)}$	Turn-off Delay Time				346		
T_f	Fall Time				40		
E_{on}	Turn-on Switching Energy	V_{GE} = 15V V_{Bus} = 400V I_C = 25A R_G = 22Ω	T_j = 125°C		3.5		mJ
E_{off}	Turn-off Switching Energy		T_j = 125°C		1.5		
R_{thJC}	Junction to Case Thermal resistance					0.6	°C/W

2.2 Bottom diode characteristics

Symbol	*Characteristic*	*Test Conditions*		*Min*	*Typ*	*Max*	*Unit*
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I_{RM}	Maximum Reverse Leakage Current	V_R=1200V	T_j = 25°C			100	µA
			T_j = 125°C			500	
I_F	DC Forward Current		Tc = 80°C		25		A
V_F	Diode Forward Voltage	I_F = 25A			2.6	3.1	V
		I_F = 50A			3.2		
		I_F = 25A	T_j = 125°C		1.8		
t_{rr}	Reverse Recovery Time	I_F = 25A V_R = 667V di/dt =200A/µs	T_j = 25°C		320		ns
			T_j = 125°C		360		
Q_{rr}	Reverse Recovery Charge		T_j = 25°C		480		nC
			T_j = 125°C		1800		
R_{thJC}	Junction to Case Thermal resistance					1.4	°C/W

3. Boost chopper switches

3.1 Fast NPT IGBT characteristics

Absolute maximum ratings

Symbol	*Parameter*		*Max ratings*	*Unit*
V_{CES}	Collector - Emitter Breakdown Voltage		1200	V
I_C	Continuous Collector Current	T_c = 25°C	70	A
		T_c = 80°C	50	
I_{CM}	Pulsed Collector Current	T_c = 25°C	150	
V_{GE}	Gate – Emitter Voltage		±20	V
P_D	Maximum Power Dissipation	T_c = 25°C	312	W
RBSOA	Reverse Bias Safe Operating Area	T_j = 150°C	100A @ 1200V	

Electrical Characteristics

Symbol	*Characteristic*	*Test Conditions*		*Min*	*Typ*	*Max*	*Unit*
I_{CES}	Zero Gate Voltage Collector Current	V_{GE} = 0V, V_{CE} = 1200V	T_j = 25°C			250	µA
			T_j = 125°C			500	
$V_{CE(sat)}$	Collector Emitter saturation Voltage	V_{GE} =15V, I_C = 50A	T_j = 25°C		3.2	3.7	V
			T_j = 125°C		4.0		
$V_{GE(th)}$	Gate Threshold Voltage	V_{GE} = V_{CE}, I_C = 1 mA		4.5		6.5	V
I_{GES}	Gate – Emitter Leakage Current	V_{GE} = 20 V, V_{CE} = 0V				100	nA

Dynamic Characteristics

Symbol	*Characteristic*	*Test Conditions*		*Min*	*Typ*	*Max*	*Unit*
C_{ies}	Input Capacitance	V_{GE} = 0V, V_{CE} = 25V, f = 1MHz			3450		pF
C_{oes}	Output Capacitance				330		
C_{res}	Reverse Transfer Capacitance				220		
Q_g	Total gate Charge	V_{GS} = 15V, V_{Bus} = 600V, I_C = 50A			330		nC
Q_{ge}	Gate – Emitter Charge				35		
Q_{gc}	Gate – Collector Charge				200		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C), V_{GE} = 15V, V_{Bus} = 600V, I_C = 50A, R_G = 5 Ω			35		ns
T_r	Rise Time				65		
$T_{d(off)}$	Turn-off Delay Time				320		
T_f	Fall Time				30		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C), V_{GE} = ±15V, V_{Bus} = 600V, I_C = 50A, R_G = 5 Ω			35		ns
T_r	Rise Time				65		
$T_{d(off)}$	Turn-off Delay Time				360		
T_f	Fall Time				40		
E_{on}	Turn-on Switching Energy	V_{GE} = ±15V, V_{Bus} = 600V, I_C = 50A, R_G = 5 Ω	T_j = 125°C		6.9		mJ
E_{off}	Turn-off Switching Energy		T_j = 125°C		3.05		
R_{thJC}	Junction to Case Thermal resistance					0.4	°C/W

3.2 Chopper diode characteristics

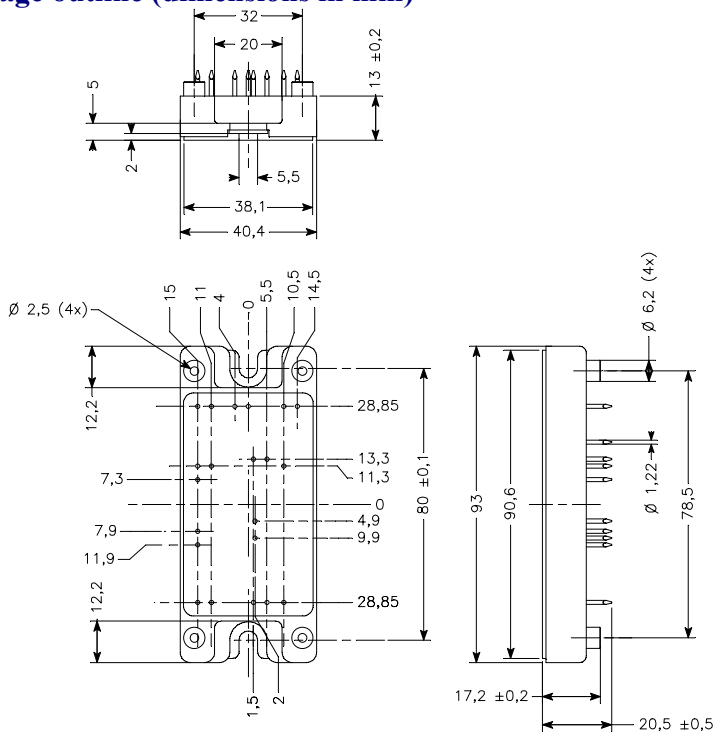
Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I_{RM}	Maximum Reverse Leakage Current	V_R=1200V	T_j = 25°C			100	µA
			T_j = 125°C			500	
I_F	DC Forward Current		Tc = 80°C		30		A
V_F	Diode Forward Voltage	I_F = 30A			2.6	3.1	V
		I_F = 60A			3.2		
		I_F = 30A	T_j = 125°C		1.8		
t_{rr}	Reverse Recovery Time	I_F = 30A V_R = 800V di/dt =200A/µs	T_j = 25°C		300		ns
			T_j = 125°C		380		
Q_{rr}	Reverse Recovery Charge		T_j = 25°C		360		nC
			T_j = 125°C		1700		
R_{thJC}	Junction to Case Thermal resistance					1.2	°C/W

4. Package characteristics

Symbol	Characteristic			Min	Typ	Max	Unit
V_{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, I isol<1mA, 50/60Hz			2500			V
T_J	Operating junction temperature range			-40		150*	°C
T_{STG}	Storage Temperature Range			-40		125	
T_C	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M5	2.5		4.7	N.m
Wt	Package Weight					160	g

* Tj=175°C for Trench & Field Stop IGBT

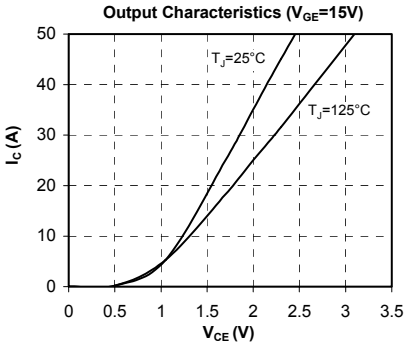
5. SP4 Package outline (dimensions in mm)

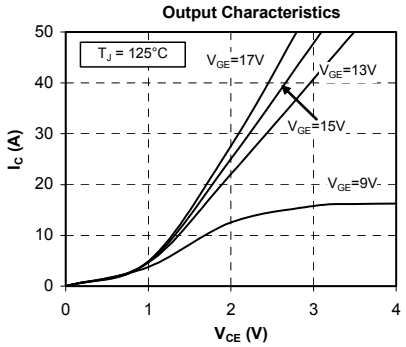


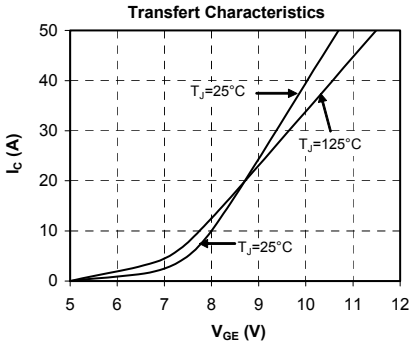
See application note APT0501 - Mounting Instructions for SP4 Power Modules on www.microsemi.com

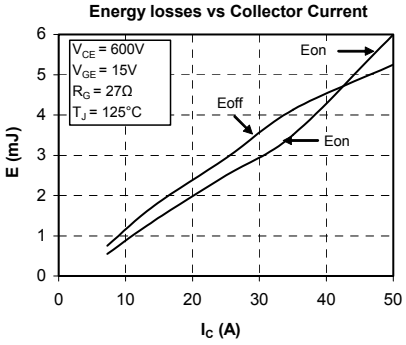
6. Full bridge top switches curves

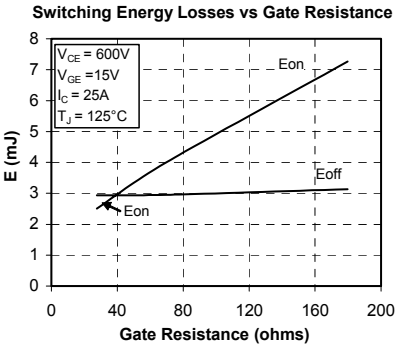
6.1 Top Trench + Field Stop IGBT typical performance curves

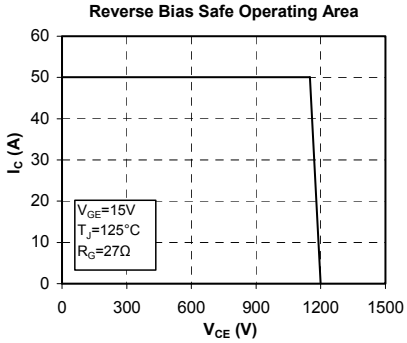


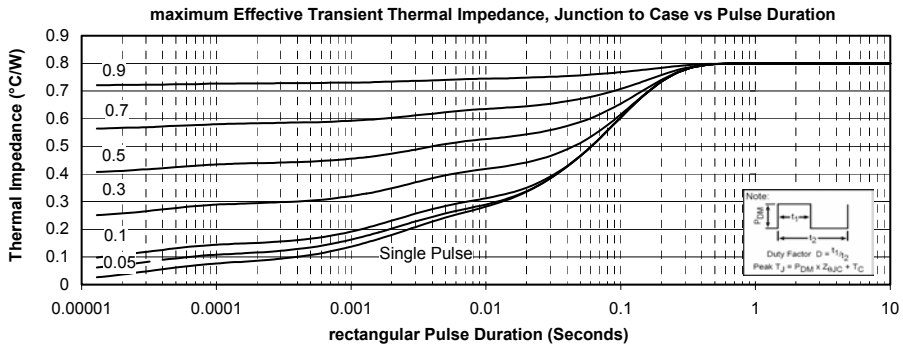




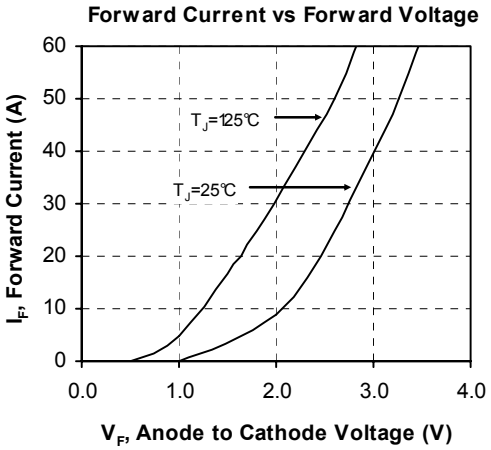


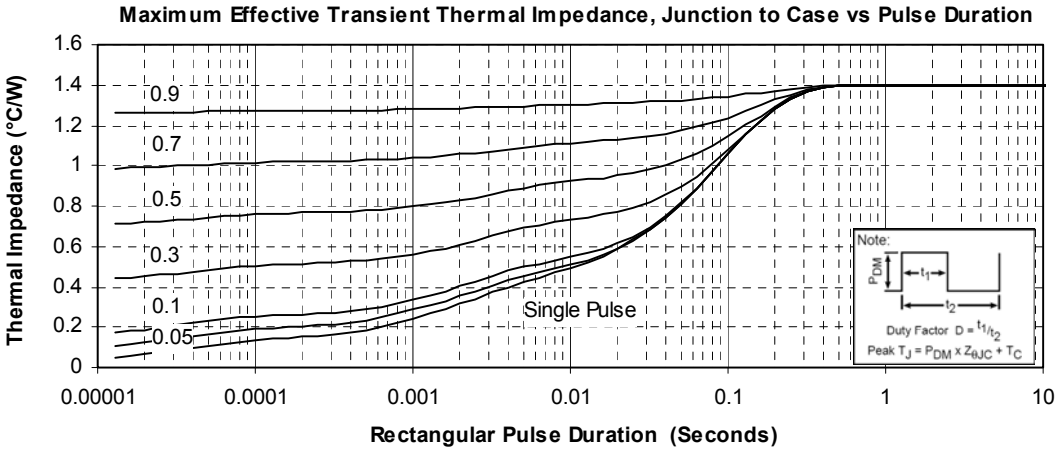






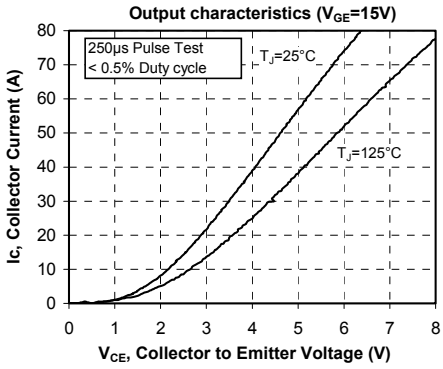
6.2 Top Fast diode typical performance curves

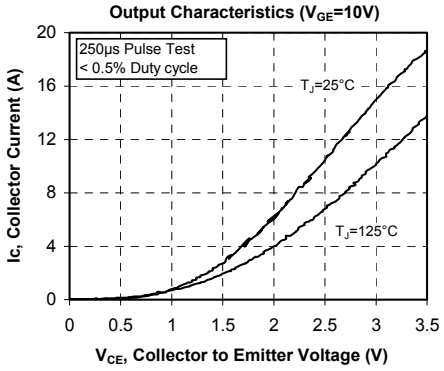


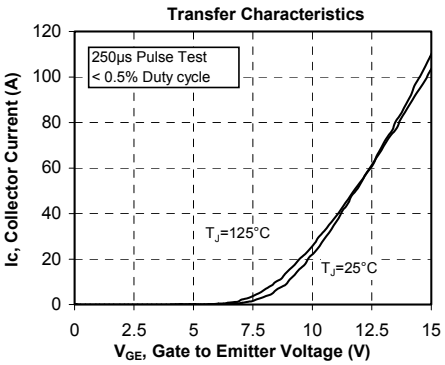


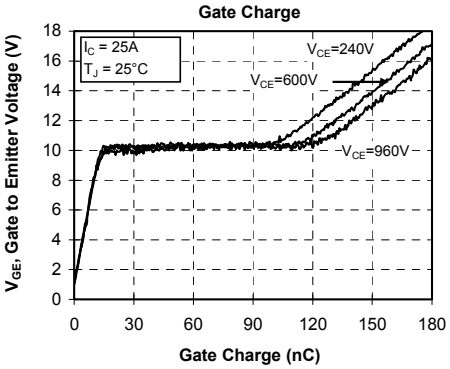
7. Full bridge bottom switches curves

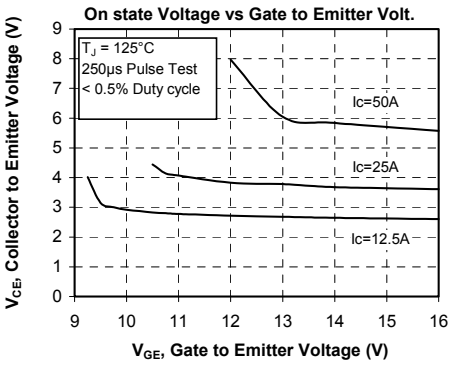
7.1 Bottom fast NPT IGBT typical performance curves

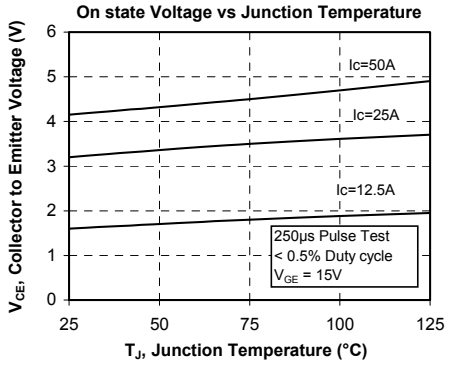


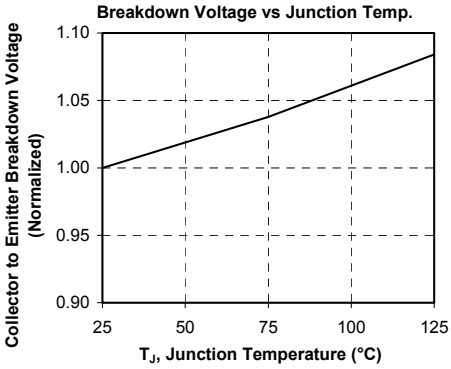


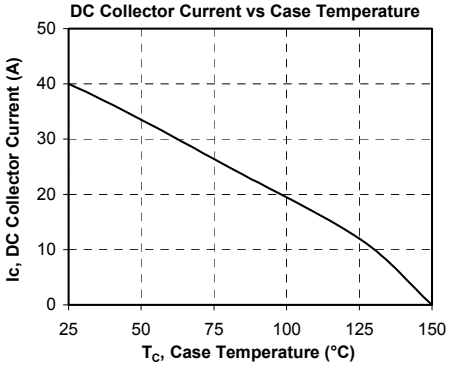




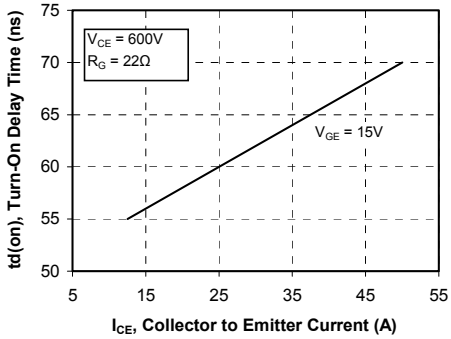




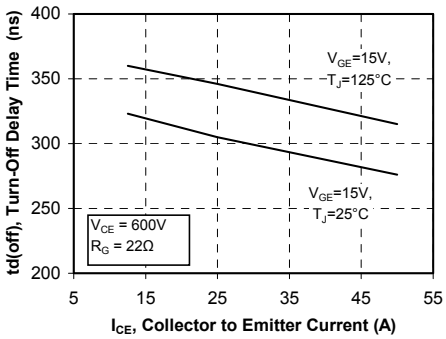




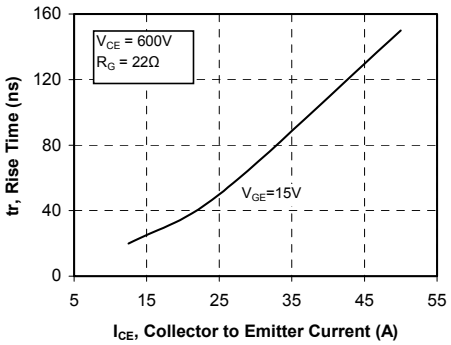
Turn-On Delay Time vs Collector Current



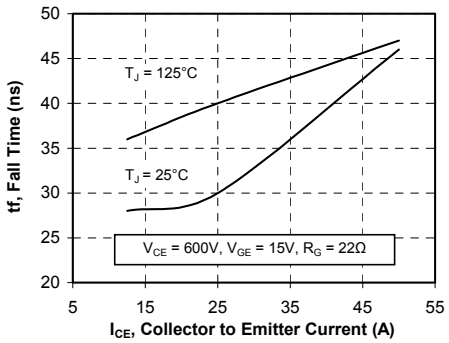
Turn-Off Delay Time vs Collector Current



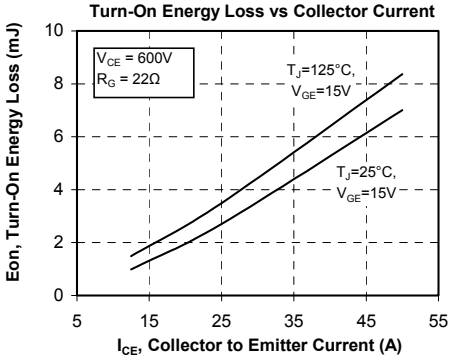
Current Rise Time vs Collector Current



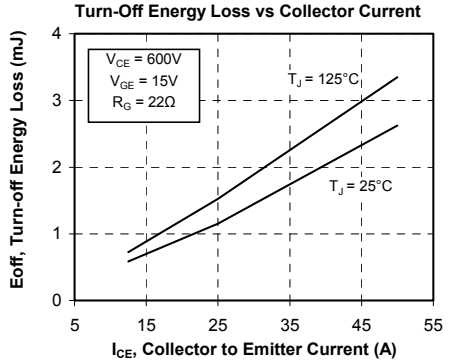
Current Fall Time vs Collector Current



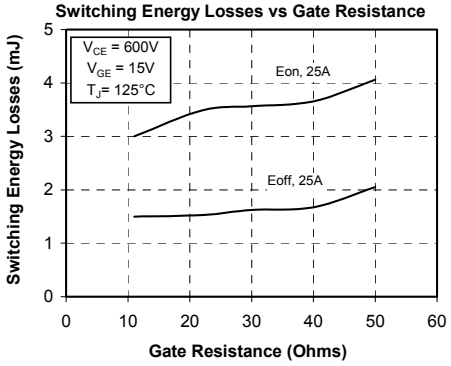
Turn-On Energy Loss vs Collector Current



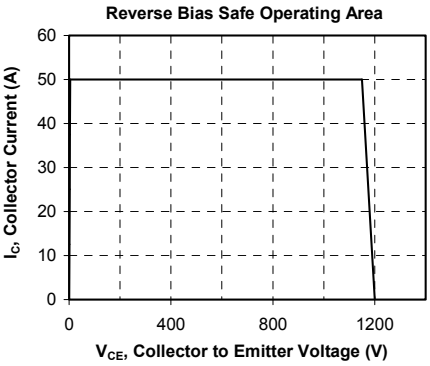
Turn-Off Energy Loss vs Collector Current

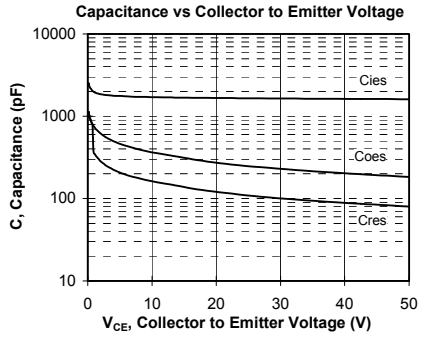


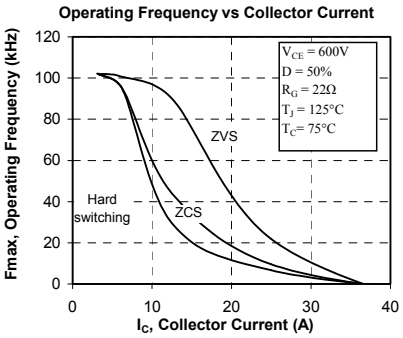
Switching Energy Losses vs Gate Resistance

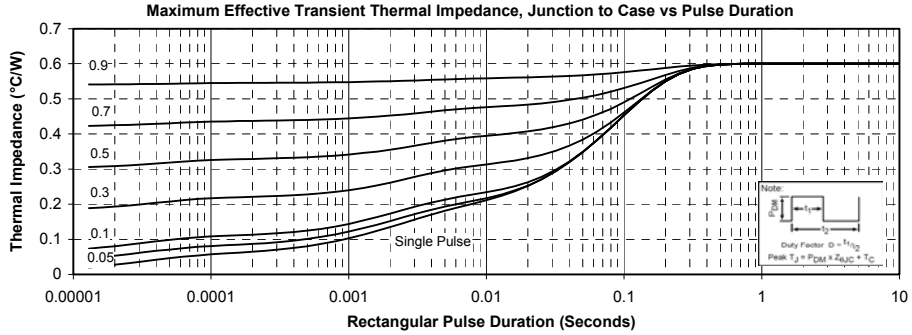


Reverse Bias Safe Operating Area

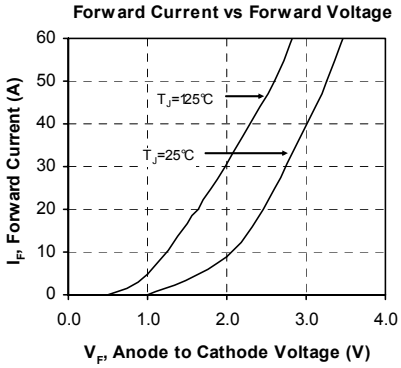


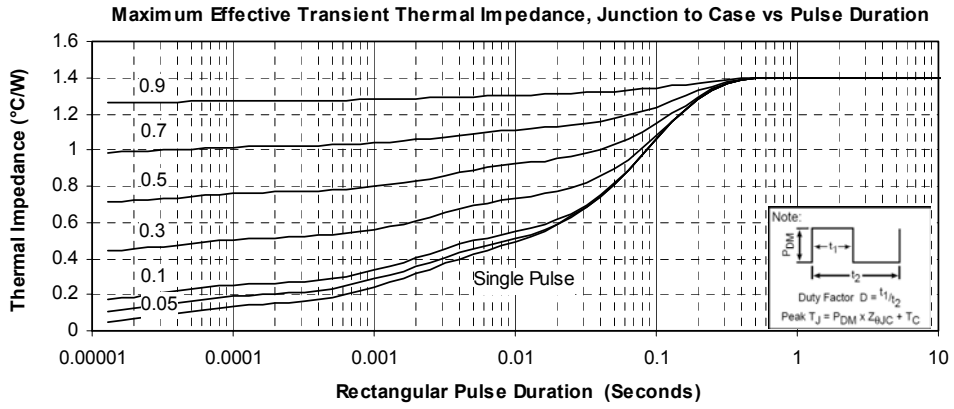






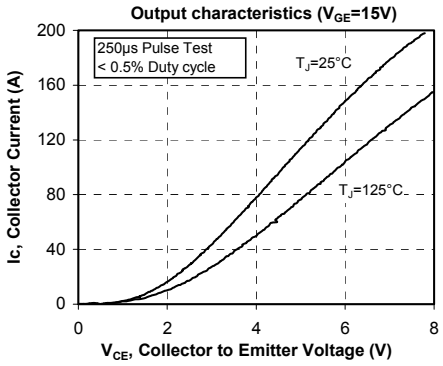
7.2 Bottom diode typical performance curves

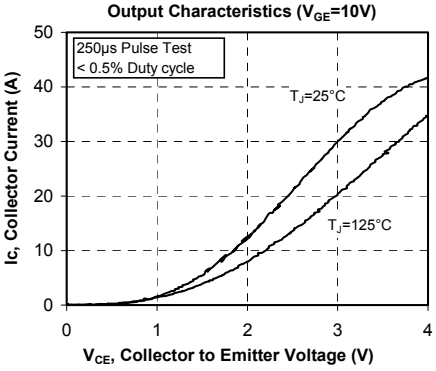


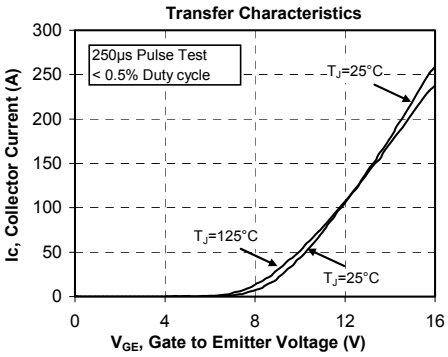


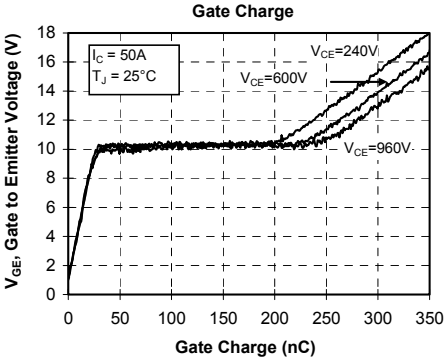
8. Boost chopper switches curves

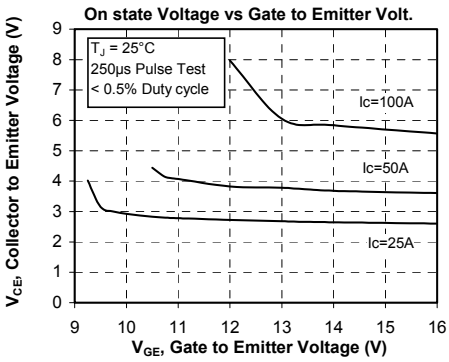
8.1 Fast NPT IGBT typical performance curves

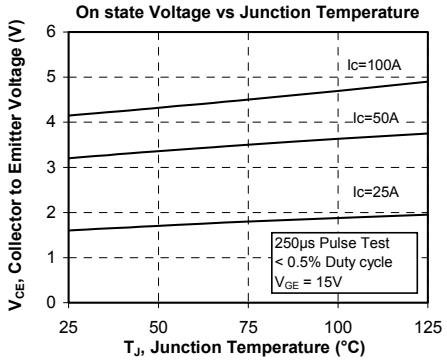


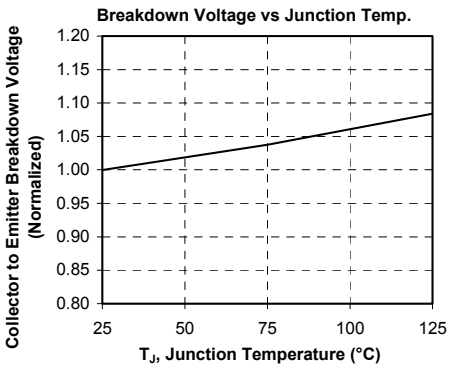


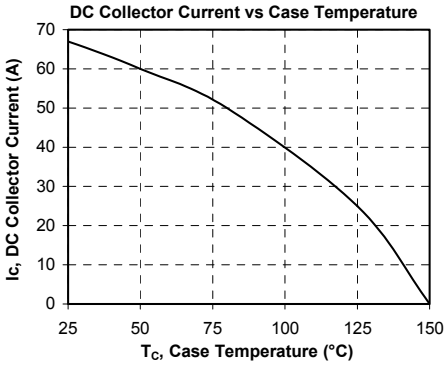




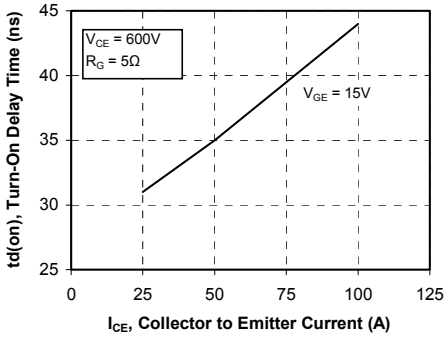




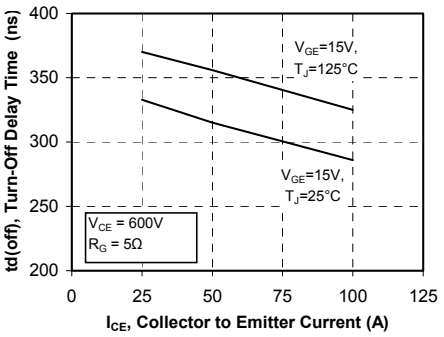




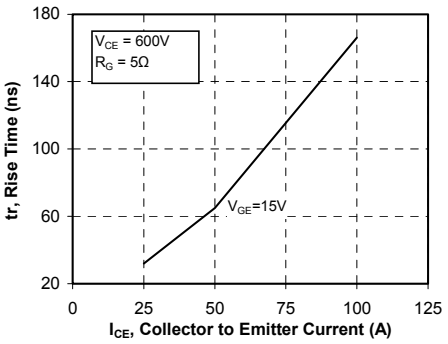
Turn-On Delay Time vs Collector Current



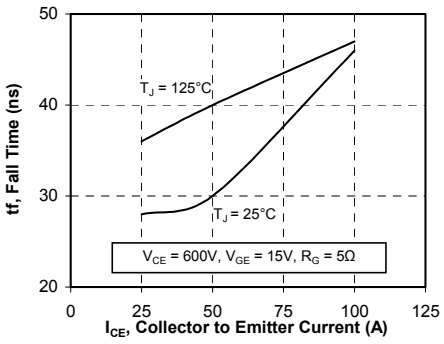
Turn-Off Delay Time vs Collector Current



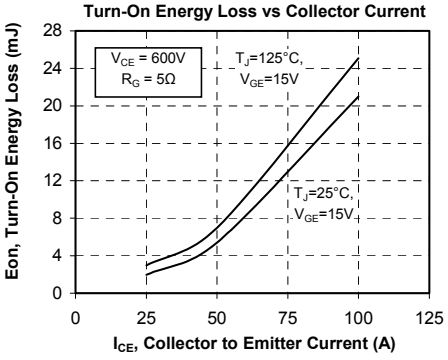
Current Rise Time vs Collector Current



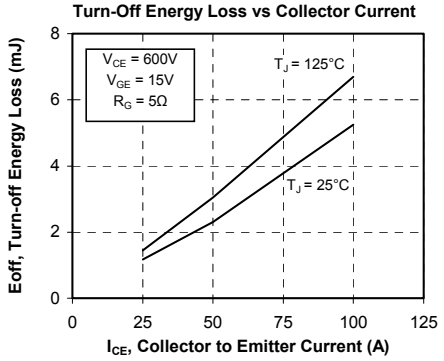
Current Fall Time vs Collector Current



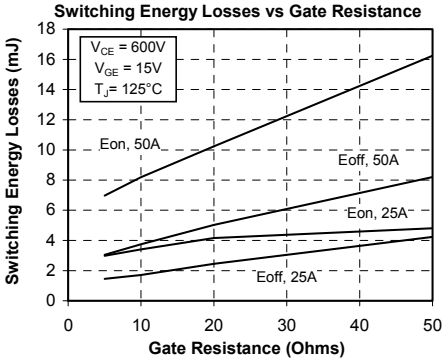
Turn-On Energy Loss vs Collector Current



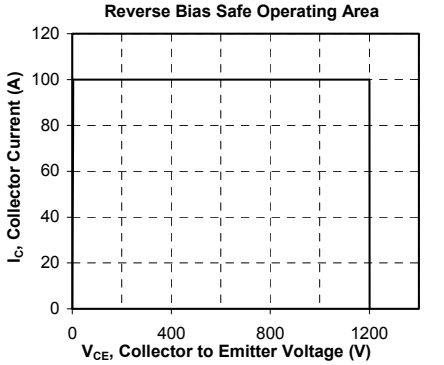
Turn-Off Energy Loss vs Collector Current

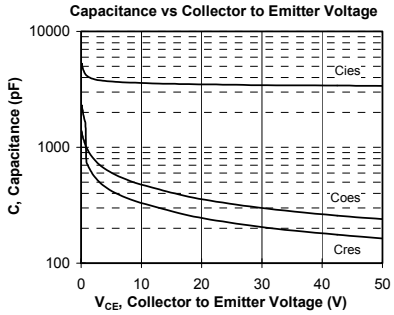


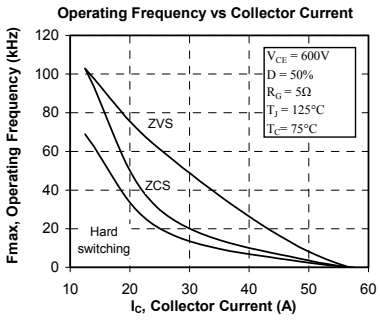
Switching Energy Losses vs Gate Resistance

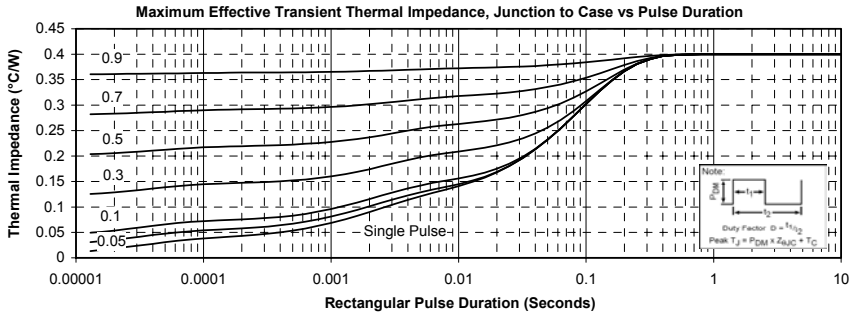


Reverse Bias Safe Operating Area









8.2 Chopper diode typical performance curves